

Notice of References Cited	Application/Control No. 10/776,380	Applicant(s)/Patent Under Reexamination NANATAKI ET AL.	
	Examiner Ryan D. Walsh	Art Unit 2852	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,411,785	06-2002	Ogawahara et al.	399/69
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	JP 11194655 A	07-1999	Japan	NANBU et al.	G03G 15/20
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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